Notice of References Cited

3
Application/Control No.
09/773,402
Examiner
Yuwen Pan

Applicant(s)/Patent Under Reexamination VASSILOVSKI ET AL.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-6,349,224	02-2002	Lim, Byung Keun	455/466	
	В	US-				
	ပ	US-				
	D	US-				
	Ε	US-				
	F	US-				
	G	US-				
	Н	US-				
	Ι	US-				
	J	US-				
	κ	US-				
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					-

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

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